	Туре	L #	Hits	Search Text	DBs	Time Stamp
1	BRS	L1	1389	evaluat\$ with grain\$4	USPAT	2004/02/09 21:10
2	BRS	L2	427	1 and (camera\$4 or scann\$4)	USPAT	2004/02/09 21:11
3	BRS	L3	47	2 and illuminat\$	USPAT	2004/02/09 21:11

- -	Comments	Error Definition	Err ors
1			0
2			0
3			0

	Ū	1	D	ocument	ID	Issue Date	Pages
1			us	6680795	B2	20040120	9
2	Ø		US	6673639	B2	20040106	30
3	×		US	6555691	B2	20030429	80
4	×		US	6551766	B1	20030422	6
5	×		US	6498010	B1	20021224	20
6	Ø		us	6483583	B1	20021119	25
7	Ø		US	6395966	В1	20020528	56
8	×		US	6312883	B1	20011106	20
9	⊠		US	6290875	B1	20010918	22

	Title	Current OR	Current XRef	Retrieval Classif
1	Underwater microscope system	359/368	359/363; 73/170.32	
2	Method and system for evaluating polysilicon, and method and system for fabricating thin film transistor	438/14	356/30; 427/8; 438/16	
3	Color developing agent, azo dye, silver halide photographic light-sensitive material, and image-forming method	548/133		
4	Process for scratch healing of motion picture films	430/432	430/12; 430/494; 430/531; 430/533; 430/934; 430/961	
5	Method for making a device for the simultaneous detection of multiple analytes	435/6	422/50; 427/261; 427/287; 427/387; 427/407.2; 435/4; 435/7.1; 436/169; 436/172; 436/173; 436/514; 436/518; 436/524; 436/535	
6	Near infrared spectrometry for real time analysis of substances	356/326	356/328; 460/7	
7	Fertile transgenic maize plants containing a gene encoding the pat protein	800/302	800/265; 800/267; 800/288; 800/320.1	
8	Photographic material having enhanced light absorption and low dye stain	430/574	430/572; 430/577; 430/583; 430/584	
9	Trivalent rare earth ion-containing aluminate phosphor, a method for producing the same and a light emitting device using the same	252/301.4R		

	Inventor	s	С	P	2	3	4	5	1	mage Doc. Displayed	PT
1	Chezar, Henry et al.	☒							US	6680795	
2	Wada, Hiroyuki et al.								US	6673639	
3	Uchida, Osamu et al.								US	6555691	
4	Smith, Thomas M. et al.								US	6551766	
5	Fitzgerald, Stephen Peter et al.								US	6498010	
6	Wright, Steven L. et al.								us	6483583	
7	Mumm, Rita Hogan et al.								US	6395966	
8	Parton, Richard L. et al.								US	6312883	
9	Oshio, Shouzo et al.								US	6290875	

	ט	1	D	ocument	ID	Issue Date	Pages
10	×		US	6247355	B1	20010619	28
11	⊠		US	6218198	B1	20010417	19
12	⊠		US	6207360	В1	20010327	68
13	⊠		US	6201885	B1	20010313	13
14	×		US	6195163	В1	20010227	23
15	Ø		US	6184456	В1	20010206	108
16	×		US	6134954	A	20001024	28
17	⊠		US	6122042	Α	20000919	44
18	⊠		US	6097493	Α	20000801	14
19	Ø		us	6066440	A	20000523	44
20	⊠		us	6059117	A	20000509	17

	Title	Current OR	Current XRef	Retrieval Classif
10	Depth sensing indentation and methodology for mechanical property measurements	73/82		
11	Method and apparatus for evaluating semiconductor film, and method for producing the semiconductor film	438/7	257/E21.527; 257/E21.53; 438/16	
12	Method for image formation and apparatus for development processing	430/434	430/419; 430/428; 430/963	
13	Method for bakery product measurement	382/110	209/576; 209/643; 209/702; 348/89; 382/100; 382/156; 382/165	
14	Reflectance method for evaluating the surface characteristics of opaque materials	356/511	250/358.1; 356/394; 356/448; 356/51	
15	Photovoltaic device	136/256	136/258	
16	Depth sensing indentation and methodology for mechanical property measurements	73/81	702/156; 702/33	
17	Devices and methods for optically identifying characteristics of material objects	356/73	356/343	
18	Device for evaluating quality of granular objects	356/609	209/580; 209/587; 356/239.1	
19	Silver halide photosensitive material and method for forming image	430/354	430/203; 430/351; 430/383; 430/405; 430/640; 430/642	
20	Method for sorting product	209/10	209/544; 209/587; 209/639	

	Inventor	S	С	P	2	3	4	5	Image Doc. Displayed	PT
10	Suresh, Subra et al.								US 6247355	
11	Imao, Kazuhiro et al.								US 6218198	
12	Ishikawa, Takatoshi et al.								US 6207360	
13	Hodgson, Allan S. et al.								US 6201885	
14	Thakur, Randhir P. S. et al.								US 6195163	
15	Matsuyama, Jinsho et al.								US 6184456	
16	Suresh, Subra et al.								US 6134954	
17	Wunderman, Irwin et al.								US 6122042	
18	Satake, Satoru et al.								US 6097493	
19	Araki, Yasushi et al.								US 6066440	
20	Novak, Thomas Joseph et al.								US 6059117	

	บ	1	D	ocument	ID	Issue Date	Pages
21	×		US	5998105	Α	19991207	54
22	⊠		US	5991025	A	19991123	20
23	×		us	5986230	A	19991116	18
24	×		US	5956413	A	19990921	10
25	×		US	5866658	A	19990202	13
26	$\boxtimes$		US	5865990	A	19990202	17
27	×		us	5835206	Α	19981110	
28	×		US	5817449	A	19981006	
29	×		US	5751780	Α	19980512	
30	×		US	5751421	A	19980512	
31	⊠		us	5712199	A	19980127	

	Title	Current OR	Current XRef	Retrieval Classif
21	Method of image formation using silver halide color photographic material	430/375	430/264; 430/363; 430/374; 430/383; 430/394; 430/598; 430/945	
22	Near infrared spectrometer used in combination with an agricultural implement for real time grain and forage analysis	356/328	460/7	
23	Method and apparatus for sorting product	209/579	209/580; 209/587; 209/588; 209/639	
24	Method and device for automatic evaluation of cereal grains and other granular products	382/110	382/156	
25	High performance ionomer blends	525/183	524/514	
26	Method and apparatus for sorting grain	209/579	209/580; 209/588; 209/639	
27	Use of color image analyzers for quantifying grain quality traits	356/72	356/406	
28	Method for forming a color image	430/399	430/398; 430/448; 430/566	
29	X-ray mask structure, preparation thereof and X-ray exposure method	378/35	378/34	
30	Near infrared spectrometer	356/328	460/7	
31	Method for making semiconductor body and photovoltaic device	438/62	257/E31.042; 438/490; 438/563	

	Inventor	s	С	P	2	3	4	5	Image Doc. Displayed	PT
21	Murakoshi, Yasuhiro								US 5998105	
22	Wright, Steven L. et al.								US 5991025	
23	Novak, Thomas Joseph et al.								US 5986230	
24	Oste, Rickard et al.								US 5956413	
25	Talkowski, Charles John								US 5866658	
26	Novak, Thomas Joseph et al.								US 5865990	
27	Tragesser, Scott									
28	Nakamura, Koichi									
29	Fukuda, Yasuaki et al.									
30	Wright, Steven L. et al.									
31	Nakagawa, Katsumi et al.									

	บ	1	Docum	ent	ID	Issue Date	Pages
32	×		US 5607	733	Α	19970304	
33	⊠		US 5508	3156	A	19960416	
34	⊠		US 5484	694	A	19960116	
35	Ø		US 5466	934	A	19951114	
36	⊠		US 5413	804	Α	19950509	
37	☒		US 5368	996	A	19941129	
38	⊠		US 5352	569	A	19941004	
39	×		US 5288	342	Α	19940222	

·	Title	Current OR	Current XRef	Retrieval Classif
32	Process for preparing an X-ray mask structure	427/585	378/35; 427/248.1; 427/258; 427/259; 427/264; 427/265; 427/270; 427/272; 427/282; 427/402; 427/419.7; 427/65; 430/5	
33	Silver halide photographic light-sensitive material	430/522	430/505; 430/603; 430/605; 430/963	
34	Imaging element comprising an electrically-conductive layer containing antimony-doped tin oxide particles		423/618; 430/533; 430/539; 430/63; 430/930	
35	Method and apparatus for identification of crystallographic defects	250/307	250/310	
36	Process for making whey-derived fat substitute product and products thereof	426/583	426/656; 426/658; 426/804; 426/89; 426/99	
37	Color photographic material	430/531	430/523; 430/536; 430/538; 430/539; 430/558; 430/950	
38	Silver halide color photographic material	430/504	430/503; 430/523; 430/530; 430/539; 430/950; 430/961; 430/965	
39	Solid metal-carbon matrix of metallofullerites and method of forming same	148/320	148/538; 148/540; 148/543; 420/129; 423/445B	

	Inventor	s	С	P	2	3	4	5	Image Doc. Displayed	PT
32	Fukuda, Yasuaki et al.									
33	Kawai, Hiroshi									
34	Lelental, Mark et al.									
35	Adams, Brent L. et al.									
36	Rhodes, Kenneth H.								·	
37	Asami, Masahiro									
38	Takada, Kiyohito									
39	Job, Robert C.									

	ŭ	1	E	ocument	ID	Issue Date	Pages
40	⊠		US	5267274	Α	19931130	
41	×		US	5252836	Α	19931012	
42	Ø		us	5149978	Α	19920922	
43	Ø		US	4868883	A	19890919	
44	×		US	4713781	A	19871215	
45			US	4504570	A	19850312	
46	×		US	4425425	A	19840110	
47	×		US	3823604	A	19740716	

02/09/2004, EAST Version: 1.4.1

	Title	Current OR	Current XRef	Retrieval Classif
40	Method of fission track analysis utilizing bulk chemical etching of apatite	376/164	250/253; 250/260; 250/472.1; 356/30; 376/158	0200022
41	Reflective grain defect scanning	250/559.18	250/559.44; 250/559.45; 356/445; 356/446	
42	Apparatus for measuring grain sizes in metalized layers	250/559.19	356/335	
43	Analysis of thin section images	382/109	382/180; 382/286	
44	Grain damage analyzer	382/110	250/222.2; 250/223R; 250/461.2; 250/910; 348/131	
45	Direct reversal emulsions and photographic elements useful in image transfer film units	430/217	430/219; 430/223; 430/503; 430/505; 430/542; 430/547; 430/550; 430/567; 430/570; 430/580; 430/581; 430/589; 430/592; 430/592; 430/598; 430/604; 430/605; 430/608; 430/642; 430/940	
46	Radiographic elements exhibiting reduced crossover	430/502	430/139; 430/569; 430/570; 430/581; 430/585; 430/966	
47	METHOD OF AND APPARATUS FOR DETECTING SURFACE FORM IRREGULARITIES	73/656	356/458; 356/512; 356/521; 359/900; 359/902	

	Inventor	s	С	P	2	3	4	5	Image Doc. Displayed	PT
40	Donelick, Raymond A.									
41	Matthews, Peter C. et al.									
42	Opsal, Jon et al.									
43	Chen, Patrick C.									
44	Brizgis, Lawrence J. et al.									
45	Evans, Francis J. et al.									
46	Abbott, Thomas I. et al.									
47	Burch, James Morriss et al.									

02/09/2004, EAST Version: 1.4.1